

## Static Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>®</sup>
	Static Drain-to-Source On-Resistance		5.4	6.8		V <sub>GS</sub> = 10V, I <sub>D</sub> = 50A <sup>(5)</sup>
R <sub>DS(on)</sub>			6.6	8.3	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 50A <sup>(5)</sup>
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$ , $I_D = 100 \mu A$
gfs	Forward Transconductance	31			S	$V_{DS} = 25V, I_{D} = 50A$
R <sub>G(int)</sub>	Internal Gate Resistance		0.6		Ω	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 60V, V_{GS} = 0V$
				250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	20	V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -16V

## Dynamic Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		33	49		I <sub>D</sub> = 50A
Q <sub>gs</sub>	Gate-to-Source Charge		11			$V_{DS} = 30V$
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		15		nC	V <sub>GS</sub> = 4.5V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		18	_		$I_{D} = 50A, V_{DS} = 0V, V_{GS} = 4.5V$
t <sub>d(on)</sub>	Turn-On Delay Time		45			V <sub>DD</sub> = 39V
t <sub>r</sub>	Rise Time		216			I <sub>D</sub> = 50A
t <sub>d(off)</sub>	Turn-Off Delay Time		43		ns	$R_{G} = 7.5 \Omega$
t <sub>f</sub>	Fall Time		69			V <sub>GS</sub> = 4.5V ⑤
C <sub>iss</sub>	Input Capacitance		3779			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		332		Ī	$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		163		pF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		437			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V \odot, \text{See Fig.11}$
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related) ©		636		Ţ	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V $

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			<b>99</b> ①		MOSFET symbol
	(Body Diode)			99 U	^	showing the
I <sub>SM</sub>	Pulsed Source Current			396	A	integral reverse
	(Body Diode) ②			390		p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_{J} = 25^{\circ}C, I_{S} = 50A, V_{GS} = 0V$ (5)
t <sub>rr</sub>	Reverse Recovery Time		27		20	$T_J = 25^{\circ}C$ $V_R = 51V$ ,
			32		ns	$T_J = 125^{\circ}C$ $I_F = 50A$
Q <sub>rr</sub>	Reverse Recovery Charge		31		nC	$T_J = 25^{\circ}C$ di/dt = 100A/µs (5)
			43			$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		2.1		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

#### Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 50A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by  $T_{Jmax}$ , starting  $T_J = 25^{\circ}C$ , L = 0.136 mH
- $R_G$  = 25 $\Omega,\,I_{AS}$  = 50A,  $V_{GS}$  =10V. Part not recommended for use above this value .
- (4)  $I_{SD} \le 50A$ , di/dt  $\le 1109 A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J \le 175^{\circ}C$ .

S Pulse width  $\leq$  400  $\mu s;$  duty cycle  $\leq$  2%.

- 6 C\_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C\_{oss} while V\_{DS} is rising from 0 to 80% V\_{DSS}.
- O C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- ⑧ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniquea refer to applocation note # AN- 994 echniques refer to application note #AN-994.
- $\circledast\ R_{\theta}$  is measured at  $T_{J}$  approximately 90°C.









V<sub>GS</sub>, Gate-to-Source Voltage (V)









Fig 2. Typical Output Characteristics











100



175



Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Fig 14. Typical Avalanche Current vs.Pulsewidth



Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.

5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).

- 6.  $I_{av}$  = Allowable avalanche current.
- 7.  $\Delta$ T = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 14, 15).
  - t<sub>av =</sub> Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av}) = Transient thermal resistance, see Figures 13)$ 

$$\begin{split} \textbf{P}_{D \;(ave)} &= 1/2 \; ( \; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \;(AR)} &= \textbf{P}_{D \;(ave)} \cdot \textbf{t}_{av} \end{split}$$





Fig 16. Threshold Voltage vs. Temperature



Fig. 18 - Typical Recovery Current vs. di<sub>f</sub>/dt



Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt



Fig. 19 - Typical Stored Charge vs. dif/dt





\*  $V_{GS}$  = 5V for Logic Level Devices





Fig 22a. Unclamped Inductive Test Circuit



Fig 23a. Switching Time Test Circuit



Fig 24a. Gate Charge Test Circuit

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Fig 22b. Unclamped Inductive Waveforms



Fig 23b. Switching Time Waveforms





ld

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# D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)









- NOTES:
- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION UNCONTROLLED IN L5.
- A DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- M DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .006 [0.15] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M	DIMENSIONS							
B	MILLIM	ETERS	INC	INCHES				
0 L	MIN.	MAX,	MIN.	MAX.	ES			
A	2,18	2.39	.086	.094				
A1	-	0.13	-	.005				
b	0.64	0.89	.025	.035				
b1	0.64	0.79	.025	.031	7			
b2	0,76	1,14	.030	.045				
b3	4.95	5.46	.195	.215	4			
С	0.46	0.61	.018	.024				
c1	0.41	0.56	.016	.022	7			
c2	0,46	0.89	.018	.035				
D	5.97	6.22	.235	.245	6			
D1	5.21	-	.205	-	4			
Ε	6.35	6.73	.250	.265	6			
E1	4.32	-	.170	-	4			
е	2.29	BSC	.090 BSC		]			
н	9.40	10,41	.370	.410				
L	1,40	1.78	.055	.070				
L1	2.74	BSC	.108	REF,	]			
L2	0.51	BSC	.020 BSC					
L3	0.89	1.27	,035	,050	4			
L4	-	1.02	-	.040				
L5	1,14	1.52	,045	.060	3			
Ø	0.	10*	0.	10*				
ø1	0"	15"	0*	15"				
ø2	25*	35°	25*	35"				

#### LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1.– GATE 2.– DRAIN
- 3.- SOURCE
- 4.- DRAIN

#### IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

# D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)





### NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.





Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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# **Qualification Information<sup>†</sup>**

Qualification Level		Automotive (per AEC-Q101) <sup>††</sup>				
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture S	ensitivity Level	D-PAK	MSL1			
	Machine Model	Class M4 (+/- 600V) <sup>†††</sup>				
		AEC-Q101-002				
ESD	Human Body Model	Class H1C (+/- 2000V) <sup>†††</sup>				
E9D		AEC-Q101-001				
	Charged Device	Class C5 (+/- 2000V) <sup>†††</sup>				
	Model	AEC-Q101-005				
RoHS Compliant		Yes				

† Qualification standards can be found at International Rectifier's web site: <u>http://www.irf.com/</u>

**††** Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

††† Highest passing voltage.



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### **Revision History**

Date	Comments				
3/18/2014	Added "Logic Level Gate Drive" bullet in the features section on page 1				
3/18/2014	<ul> <li>Updated data sheet with new IR corporate template</li> </ul>				
4/9/2014	Updated package outline on page 8.				
4/9/2014	• Updated typo on the fig.19 and fig.20, unit of y-axis from "A" to "nC" on page 6.				

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